Se	earch N	otes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/632,791	YAMADA ET AL.	
Examiner	Art Unit	
 Timothy C. Vanoy	1754	

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Class	Subclass	Date	Examiner
423	2	4/17/2006	300 300 300 300
423	3	4/17/2006	254
423	11	4/17/2006	200
423	16	4/17/2006	200
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